

## 20V N-MOS

- Features**

$R_{DS(ON)} < 360m\Omega @ V_{GS} = 4.5V$   
 $R_{DS(ON)} < 420m\Omega @ V_{GS} = 2.5V$   
 $R_{DS(ON)} < 560m\Omega @ V_{GS} = 1.8V$   
 Low Offset (Error) Voltage  
 Low-Voltage Operation  
 High-Speed Circuits  
 Low Battery Voltage Operation  
 FBP1006-3 package design

- APPLICATIONS**

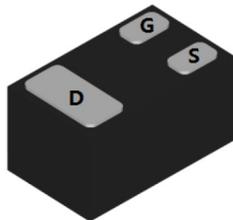
Drivers: Relays, Solenoids, Lamps, Hammers, Displays, Memories  
 Battery Operated Systems  
 Power Supply Converter Circuits  
 Load/Power Switching Smart Phones, Pagers

- General Description**

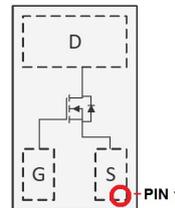
FS2022, N-Channel enhancement mode MOSFET, uses Advanced Trench Technology to provide excellent  $R_{DS(ON)}$ , low gate charge.

These devices are particularly suited for low voltage power management, such as smart phone and notebook computer, and low in-line power loss are needed in commercial industrial surface mount applications.

- Pin Configurations**



FBP1006-3



Pin configuration (Top view)

- Absolute Maximum Ratings @ $T_A = 25^\circ C$  unless otherwise noted**

Parameter	Symbol	Ratings	Unit
Drain - Source Voltage	$V_{DSS}$	20	V
Gate -Source Voltage	$V_{GS}$	$\pm 12$	V
Drain Current (Continuous)	$I_D$	0.70	A
Drain Current (Pulse)	$I_{DP}$	1.0	A
Power Dissipation	$P_D$	0.27	W
Operating Temperature	$T_J$	-55~150	$^\circ C$
Storage Temperature	$T_{STG}$	-55~150	$^\circ C$

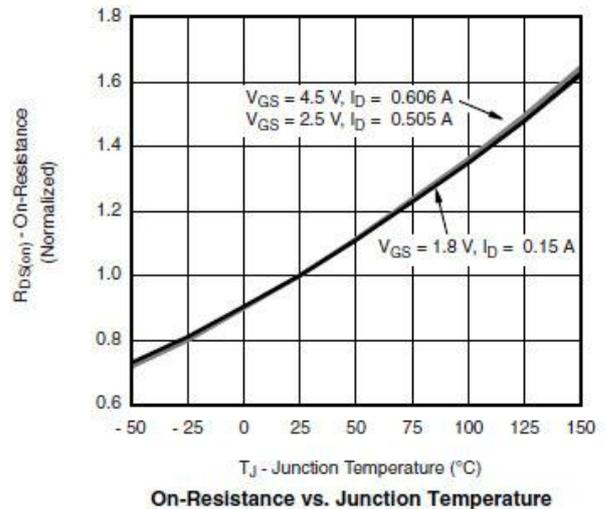
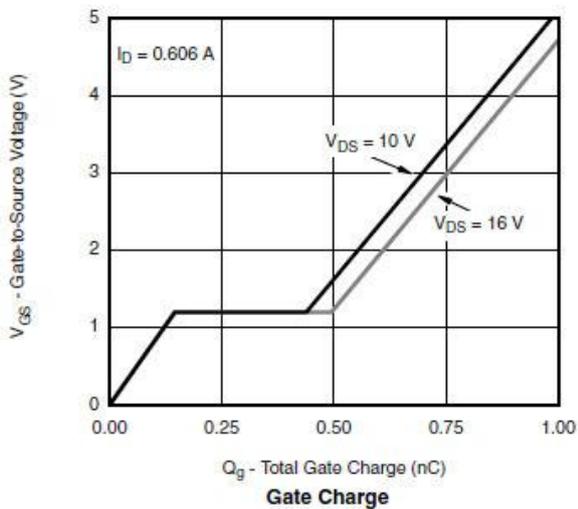
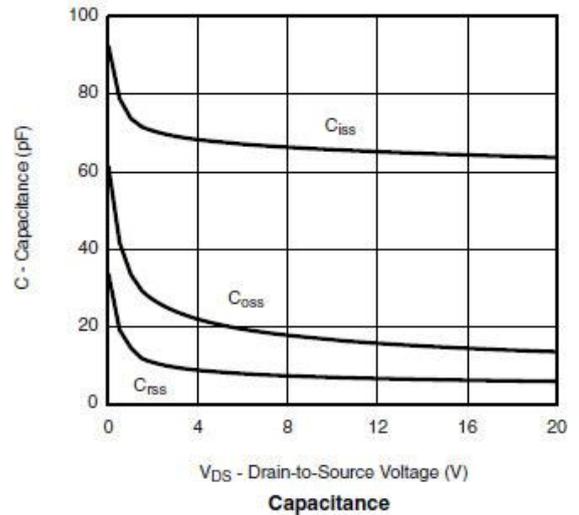
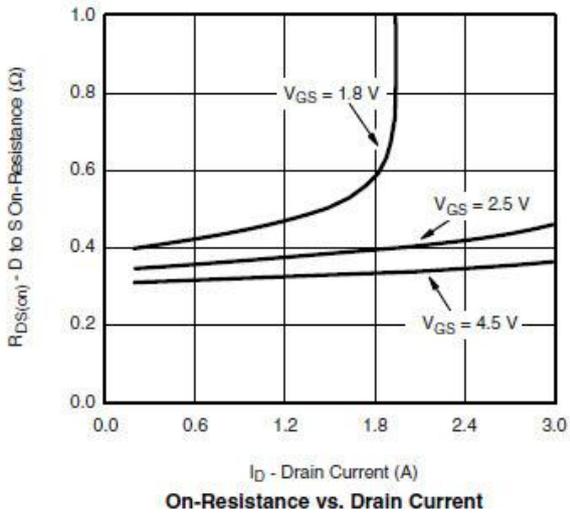
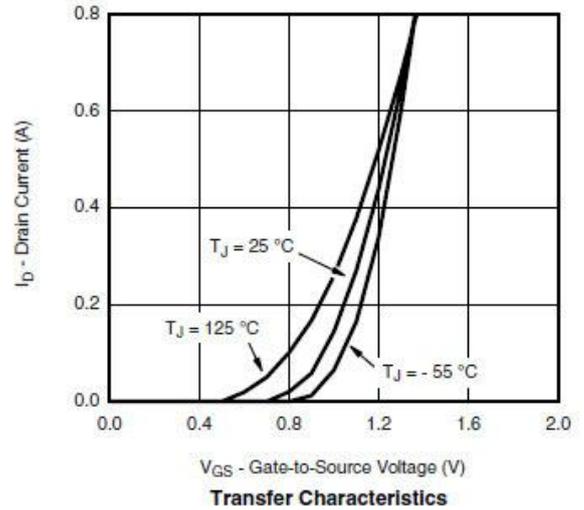
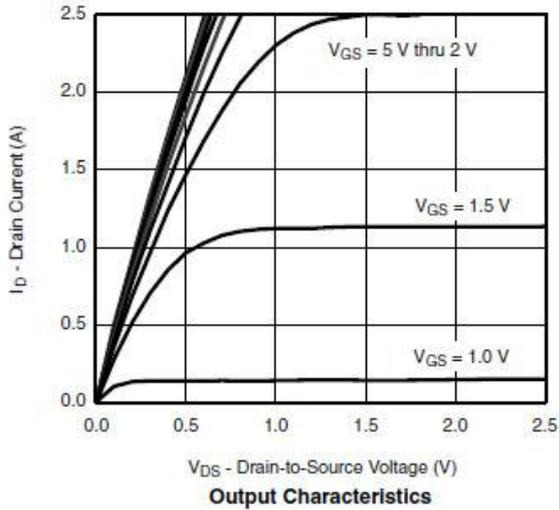
● **Electrical Characteristics** @ $T_A=25^\circ\text{C}$  unless otherwise noted

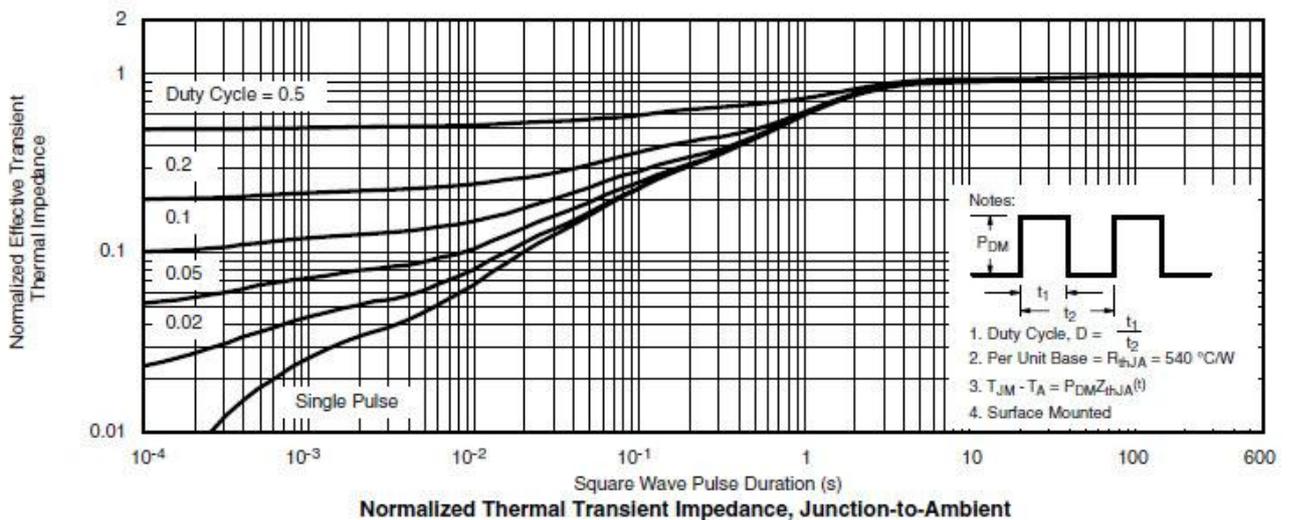
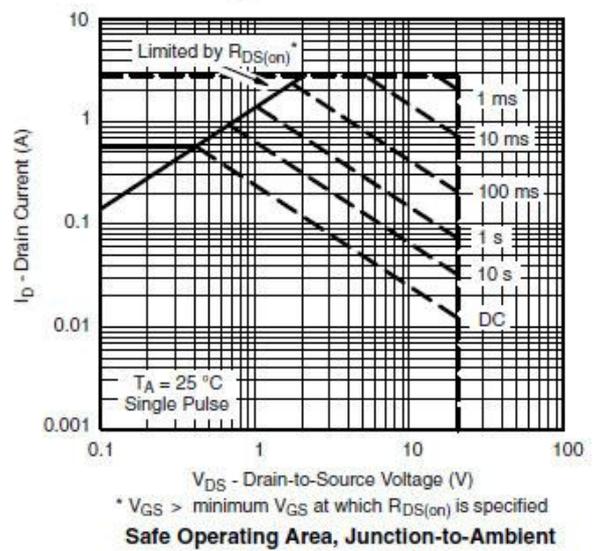
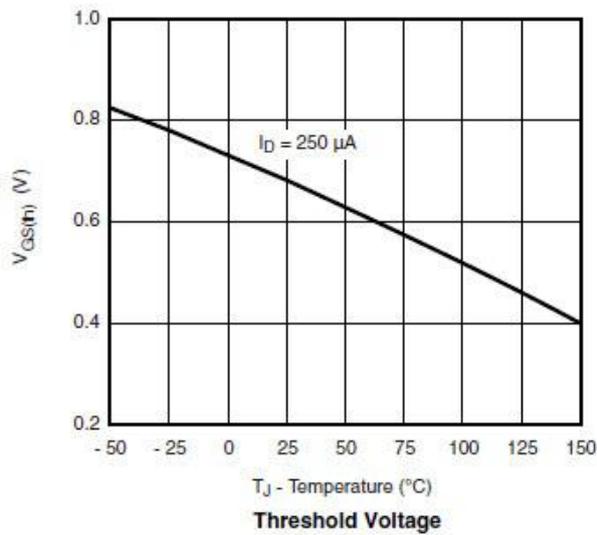
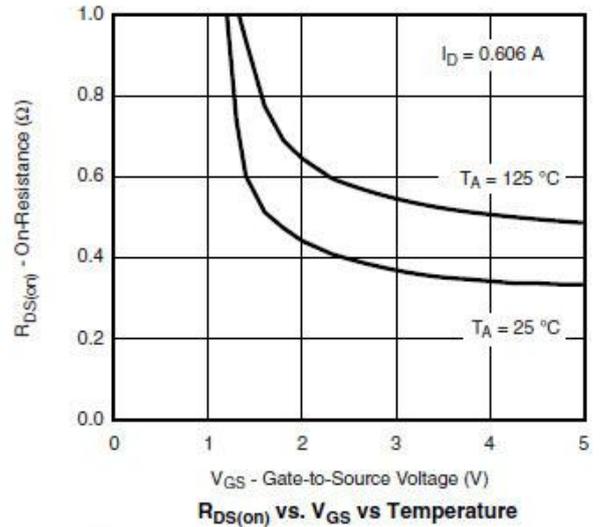
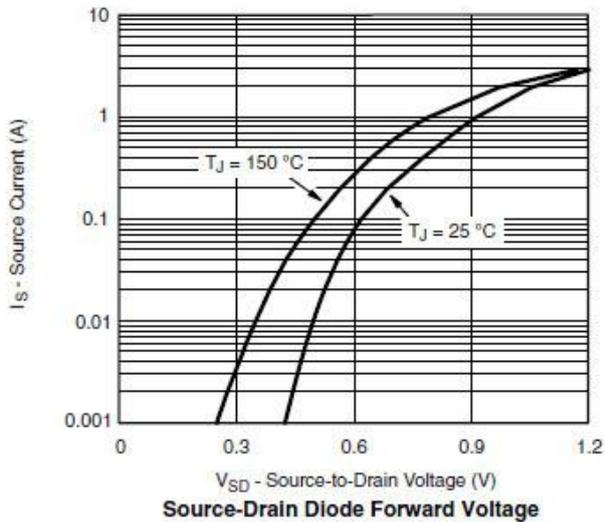
Symbol	Parameter	Limit	Min	Typ	Max	Unit
<b>STATIC</b>						
$BV_{DSS}$	Drain-Source Breakdown Voltage	$V_{GS}=0V, I_D=250\ \mu\text{A}$	20			V
$V_{GS(th)}$	Gate Threshold Voltage	$V_{DS}=V_{GS}, I_D=250\ \mu\text{A}$	0.4		1.0	
$I_{GSS}$	Gate Leakage Current	$V_{DS}=0V, V_{GS}=\pm 12V$			$\pm 0.1$	$\mu\text{A}$
$I_{DSS}$	Zero Gate Voltage Drain Current	$V_{DS}=20V, V_{GS}=0V$			1	
$R_{DS(on)}$	Drain-Source On-Resistance	$V_{GS}=4.5V, I_D=0.8A$		300	360	$\text{m}\Omega$
		$V_{GS}=2.5V, I_D=0.7A$		340	420	
		$V_{GS}=1.8V, I_D=0.6A$		420	560	
$G_{FS}$	Forward Transconductance	$V_{DS}=10V, I_D=0.4A$		1.0		S
$V_{SD}$	Diode Forward Voltage	$I_S=0.15A, V_{GS}=0V$		0.65	1.2	V
<b>DYNAMIC</b>						
$Q_{g(TOT)}$	Total Gate Charge	$V_{DS}=10V, V_{GS}=4.5V, I_D=0.6A$		1.06		nC
$Q_{gs}$	Gate-Source Charge			0.18		
$Q_{gd}$	Gate-Drain Charge			0.32		
$C_{iss}$	Input Capacitance	$V_{DS}=10V, V_{GS}=0V, f=1\text{MHz}$		70		pF
$C_{oss}$	Output Capacitance			20		
$C_{rss}$	Reverse Transfer Capacitance			8		
$t_{d(on)}$	Turn-On Delay Time	$V_{DS}=10V, R_G=1\Omega$ $I_D=0.5A, V_{GS}=4.5V, R_L=20\Omega$		18	26	ns
$t_r$	Rise Time			20	28	
$t_{d(off)}$	Turn-Off Delay Time			70	110	
$t_f$	Fall Time			25	40	

Notes:

1. Pulse width limited by maximum junction temperature. Pulse test:  $PW \leq 300\ \mu\text{s}$ , duty cycle  $\leq 2\%$ .
2. For design AID only, not subject to production testing. Switching time is essentially independent of operating temperature.

- Typical Performance Characteristics





- Package Information ( FBP1006-3 )

## WBFBP-03E (1.0×0.6×0.5)

